

# Search Notes



Application/Control No.

10/656,409

Examiner

Randall Chin

Applicant(s)/Patent under Reexamination

D'AGUANNO, FRANCIS D.

Art Unit

1744

## SEARCHED

Class	Subclass	Date	Examiner
15	185		
15	236.01		
15	236.05		
15	236.06		
15	236.07		
15	236.08		
15	236.09		
30	153		
30	255		
7	128		
81	177.6		
81	177.7		
81	427.5	9/18/2006	RC

UPDATED SRCH 4/18/07 RC

UPDATED SRCH 7/24/07 RC

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
PG-PUB TEXT			
SRCH - SEE			
SRCH HISTORY			
PRINTOUT		7/24/07	RC

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EAST, OCR, EPO, JPO, DERWENT		
Inventor name search		
Hwei-Siu Payer, Cl. 30 search		
Debra Meislin, Cl. 7 and 81 search	9/18/2006	RC

04/18/07  
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